## **Master Thesis Report**

Process Enhancement by Incorporating Negative Instances in Model Repair

**Final Report** 

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### **Outlines**

- Problem Review
- Demo Presentation
- Algorithm & Implementation
  - Add long-term dependency
  - Create dfg model
- Evaluation
- Appendix
  - Aided Plugin
    - Assign labels
    - Edit Process Tree
  - Reference





### **Problem Introduction**

### Description

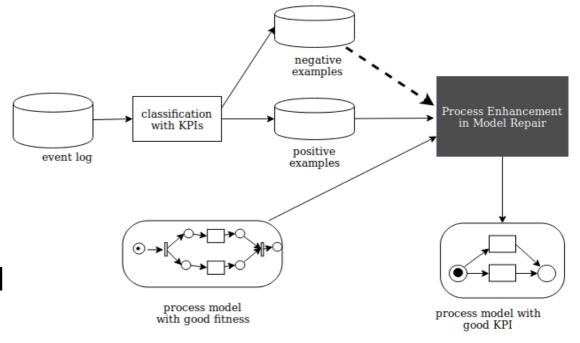
- Given event log, process model and KPIs, how to incorporate negative KPIs outcomes to repair the process model for better performance?

### Input

- Event log
- Existing process model
- KPIs

### Output

- Repaired process model





## **Demo Representation**

### Repair Model

- Sequence
- And
- Nested xor

#### Evaluate Model

Confusion matrix





## Long-term dependency

- On Petri net
- Choices Dependency
  - exclusive blocks => xor block, not loop
- Partial Order
  - Least Common Ancestor is Seq
  - ✓ In same level
- Relation xor branches
  - Significant correlation
- Connected not complete



#### Correlation

Supported Connection

$$SC(XORB_X, XORB_Y) = F_{pos}(XORB_X, XORB_Y) - F_{neg}(XORB_X, XORB_Y),$$
  
 $with F_{pos}(XORB_X, XORB_Y), F_{neg}(XORB_X, XORB_Y)$  are the frequency  
of coexistence of  $XORB_X, XORB_Y$ 

Significant Correlation if

$$SC(XORB_X, XORB_Y) >$$
lt-threshold

- Disadvantages:
  - Generate unsound model
    - Some xor branches kept from the existing model but with no frequency in event log, no long-term dependency shows to make model unsound





### Rephrased Correlation

- Existing model, positive and negative event log
- Normalized Correlation

$$Wlt(XORB_{X}, XORB_{Y}) = Wltext(XORB_{X}, XORB_{Y}) + Wltpos(XORB_{X}, XORB_{Y})$$

$$- Wltneg(XORB_{X}, XORB_{Y}), with$$

$$W_{l}text(XORB_{X}, XORB_{Y}) = \frac{1}{|XORB_{Y*}|}, XORB_{Y*}$$
is the set of all xor branches from  $XORB_{X}$ 

$$Wltpos(XORB_{X}, XORB_{Y}) = \frac{F_{pos}(XORB_{X}, XORB_{Y})}{F_{pos}(XORB_{X}, *)}$$

$$Wltneg(XORB_{X}, XORB_{Y}) = \frac{F_{neg}(XORB_{X}, XORB_{Y})}{F_{neg}(XORB_{X}, *)}$$





# Algorithm – generate dfg model

### Directly-follows relation

Existing model, positive and negative event log

$$W(A,B) := W(E_{G_{ext}}(A,B)) + W(E_{G_{pos}}(A,B)) - W(E_{G_{neg}}(A,B)), with$$

$$W(E_{G_{ext}}(A,B)) = \frac{1}{|Y*|}, \text{ the set of all possible activities after A}$$

$$W(E_{G_{pos}}(A,B)) = \frac{Cardinality_{pos}(E(A,B))}{Cardinality_{pos}(E(A,*))},$$

$$W(E_{G_{neg}}(A,B)) = \frac{Cardinality_{neg}(E(A,B))}{Cardinality_{neg}(E(A,*))},$$

- Keep this directly-follows relation if





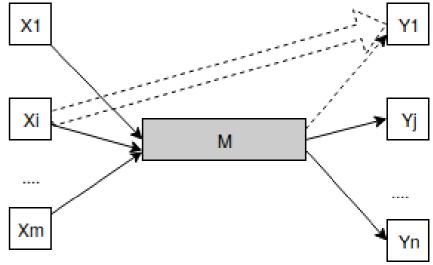
#### Key Problem to Solve

 Given a process tree, a pair of xor block A,B, the obligatory part between A,B are M, what's the relation of threshold and lt-threshold, such that?

 $\forall XORB_Y \in B, ifW(M, XORB_Y j) > threshold$ , then there exists one  $XORB_X i \in B_A$  with  $Wlt(XORB_X i, XORB_Y j) > lt$ -threshold

#### Situations

- Lt-dependency only kept from existing
   model, not showing in positive and negative
   ==> add It dependency on it
- Only It in negative==> choose the rest parts to connect
- Only in positive
  - ==> keep It
- In positive and negative
  - ==> how to decide ??







## Appendix - References

Assign Labels

Edit Process Tree



# **Appendix – references**



